



PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

GOTKIS

Application No: 10/810,209

Filed: March 26, 2004

For: METHOD AND APPARATUS FOR
MEASUREMENT OF THIN FILMS AND
RESIDUES ON SEMICONDUCTOR
SUBSTRATES)
) Group Art Unit: 1765
)
) Examiner: Anita Karen Alanko
)
) Atty. Docket No: LAM2P466
)
) Date: July 5, 2006
)
)
)
)07/11/2006 CNEGA1 00000030 10610209
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CERTIFICATE OF MAILING
I hereby certify that this correspondence is being
deposited with the United States Postal Service as First
Class Mail to: Commissioner for Patents, Alexandria, VA
22313-1450, on July 5, 2006.
Signed: Kay Harlow

Kay Harlow

REQUEST FOR CONTINUED EXAMINATION (RCE) TRANSMITTALMail Stop: **RCE**
Commissioner for Patents
Alexandria, VA 22313-1450

Sir:

This is a Request for Continued Examination (RCE) under 37 CFR 1.114 of the above-identified application.

1. Submission required under 37 C.F.R. § 1.114

- a. ☐ Previously submitted
- i. ☐ Consider the amendment(s)/reply under 37 C.F.R. § 1.116 previously filed on _____.
- ii. ☐ Consider the arguments in the Appeal Brief or Reply Brief previously filed on _____.
- iii. ☐ Other _____.
- b. ☒ Enclosed
- i. ☒ Amendment/Reply
- ii. ☐ Affidavit(s)/Declaration(s)
- iii. ☐ Information Disclosure Statement (IDS)
- iv. ☐ Other _____

2. Miscellaneous

- a. ☐ Suspension of action on the above-identified application is requested under 37 C.F.R. § 1.103(c) for a period of _____ months.
- b. ☐ Other _____

3. Fees

- a. ☒ Check in the amount of \$790.00 is enclosed for:
- i. ☒ RCE fee required under 37 C.F.R. § 1.17(e);
- ii. ☐ Extension of time fee (37 C.F.R. §§ 1.136 and 1.17); and
- iii. ☐ Other _____.
- b. ☒ The Director is hereby authorized to charge any fees, or credit any overpayments, to Deposit Account No. 50-0805 (Order No. LAM2P466).

Date: July 5, 2006Albert S. Penilla, Esq.
Registration No. 39,487